## Search Notes



Application/Control No.

10575564

Reexamination

TANAKA ET AL.

Applicant(s)/Patent Under

Examiner

Leung, Quyen P

Art Unit

2874

## **SEARCHED**

Class	Subclass	Date	Examiner
385	14, 15, 31-32, 39, 47, 50, 129-132	10/24/07	QPL

## **SEARCH NOTES**

Search Notes	Date	Examiner
US PTO EAST DATABASE SEARCHED		

## **INTERFERENCE SEARCH**

Class	Subclass	Date	Examiner
	US PGPUBS TEXT SEARCHED	10/24/07	QPL

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Part of Paper No.: 20071023